

DOCUMENT CHANGE REQUEST

DCR number 414 Changes required for: N/A Originator: Aissa Nehdi

Date: 2008/06/18 Date sent: 2008/06/18 Organisation: CNES

Status: IMPLEMENTED

Title: Transistors Low Power PNP, based on type 2N5401

Number: 5202/014 Issue: 2

Other documents affected:

Page:

2.4.1 Room Temperature Electrical Measurements

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Paragraph:

2.4.1 Room Temperature Electrical Measurements

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Original wording:

Proposed wording:

Small-Signal Current Gain hfe

Test Condition: VCE=-10V;IC=-10mA; f=10MHz; Note 2

Limit Min: 5

Justification:

The original frequency condition for A.C. Forward Current Transfer Ratio (now Small-Signal Current Gain), 10kHz, was incorrect. Please note that STMicroelectronics has always tested this parameter using f=10MHz.

Attachments:
N/A
Modifications:
N/A
Approval signature:
12. Cari-q
Date signed:
2008-06-18